

TPIC5303

3-CHANNEL INDEPENDENT GATE-PROTECTED POWER DMOS ARRAY

SLIS039A – SEPTEMBER 1994 – REVISED SEPTEMBER 1995

absolute maximum ratings over operating case temperature range (unless otherwise noted)†

Drain-to-source voltage, V_{DS}	60 V
Source-to-GND voltage (Q1, Q2, and Q3)	100 V
Drain-to-GND voltage (Q1, Q2, and Q3)	100 V
Gate-to-source voltage range, V_{GS}	-9 V to 18 V
Continuous drain current, each output, $T_C = 25^\circ\text{C}$	1.4 A
Continuous source-to-drain diode current, $T_C = 25^\circ\text{C}$	1.4 A
Pulsed drain current, each output, I_{max} , $T_C = 25^\circ\text{C}$ (see Note 1 and Figure 15)	5 A
Continuous gate-to-source zener-diode current, $T_C = 25^\circ\text{C}$	± 50 mA
Pulsed gate-to-source zener-diode current, $T_C = 25^\circ\text{C}$	± 500 mA
Single-pulse avalanche energy, E_{AS} , $T_C = 25^\circ\text{C}$ (see Figures 4, 15, and 16)	10.2 mJ
Continuous total power dissipation, $T_C = 25^\circ\text{C}$ (see Figure 15)	1.08 W
Operating virtual junction temperature range, T_J	-40°C to 150°C
Operating case temperature range, T_C	-40°C to 125°C
Storage temperature range, T_{stg}	-65°C to 150°C
Lead temperature 1,6 mm (1/16 inch) from case for 10 seconds	260°C

† Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTE 1: Pulse duration = 10 ms, duty cycle = 2%

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electrical characteristics, $T_C = 25^\circ\text{C}$ (unless otherwise noted)

PARAMETER		TEST CONDITIONS		MIN	TYP	MAX	UNIT
$V_{(BR)DSX}$	Drain-to-source breakdown voltage	$I_D = 250\ \mu\text{A}$,	$V_{GS} = 0$	60			V
$V_{GS(th)}$	Gate-to-source threshold voltage	$I_D = 1\ \text{mA}$, See Figure 5	$V_{DS} = V_{GS}$,	1.5	1.8	2.2	V
$V_{(BR)GS}$	Gate-to-source breakdown voltage	$I_{GS} = 250\ \mu\text{A}$		18			V
$V_{(BR)SG}$	Source-to-gate breakdown voltage	$I_{SG} = 250\ \mu\text{A}$		9			V
$V_{(BR)}$	Reverse drain-to-GND breakdown voltage (across D1, D2, D3)	Drain-to-GND current = $250\ \mu\text{A}$		100			V
$V_{DS(on)}$	Drain-to-source on-state voltage	$I_D = 1.4\ \text{A}$, See Notes 2 and 3	$V_{GS} = 10\ \text{V}$,		0.56	0.64	V
$V_{F(SD)}$	Forward on-state voltage, source-to-drain	$I_S = 1.4\ \text{A}$, $V_{GS} = 0$ (Z1, Z2, Z3), See Notes 2 and 3 and Figure 12			0.9	1.1	V
V_F	Forward on-state voltage, GND-to-drain	$I_D = 1.4\ \text{A}$ (D1, D2, D3), See Notes 2 and 3			5		V
I_{DSS}	Zero-gate-voltage drain current	$V_{DS} = 48\ \text{V}$, $V_{GS} = 0$	$T_C = 25^\circ\text{C}$	0.05	1		μA
			$T_C = 125^\circ\text{C}$	0.5	10		
I_{GSSF}	Forward-gate current, drain short circuited to source	$V_{GS} = 15\ \text{V}$,	$V_{DS} = 0$		20	200	nA
I_{GSSR}	Reverse-gate current, drain short circuited to source	$V_{SG} = 5\ \text{V}$,	$V_{DS} = 0$		10	100	nA
I_{lkg}	Leakage current, drain-to-GND	$V_{DGND} = 48\ \text{V}$	$T_C = 25^\circ\text{C}$	0.05	1		μA
			$T_C = 125^\circ\text{C}$	0.5	10		
$r_{DS(on)}$	Static drain-to-source on-state resistance	$V_{GS} = 10\ \text{V}$, $I_D = 1.4\ \text{A}$, See Notes 2 and 3 and Figures 6 and 7	$T_C = 25^\circ\text{C}$	0.4	0.46		Ω
			$T_C = 125^\circ\text{C}$	0.62	0.66		
g_{fs}	Forward transconductance	$V_{DS} = 15\ \text{V}$, See Notes 2 and 3 and Figure 9	$I_D = 0.7\ \text{A}$,	1	1.19		S
C_{iss}	Short-circuit input capacitance, common source			107	137		pF
C_{oss}	Short-circuit output capacitance, common source	$V_{DS} = 25\ \text{V}$,	$V_{GS} = 0$,	71	89		
C_{rss}	Short-circuit reverse transfer capacitance, common source	$f = 1\ \text{MHz}$,	See Figure 11	22	28		

NOTES: 2. Technique should limit $T_J - T_C$ to 10°C maximum.

3. These parameters are measured with voltage-sensing contacts separate from the current-carrying contacts.

source-to-drain and GND-to-drain diode characteristics, $T_C = 25^\circ\text{C}$

PARAMETER		TEST CONDITIONS		MIN	TYP	MAX	UNIT
t_{rr}	Reverse-recovery time	$I_S = 0.7\ \text{A}$, $V_{GS} = 0$, See Figures 1 and 14	$V_{DS} = 48\ \text{V}$, $di/dt = 100\ \text{A}/\mu\text{s}$,	Z1, Z2, and Z3	92		ns
				D1, D2, and D3	244		
Q_{RR}	Total diode charge			Z1, Z2, and Z3	0.1		μC
				D1, D2, and D3	1.3		



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resistive-load switching characteristics, $T_C = 25^\circ\text{C}$

PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
$t_{d(on)}$ Turn-on delay time	$V_{DD} = 25\text{ V}$, $R_L = 36\ \Omega$, $t_{r1} = 10\text{ ns}$, See Figure 2		25	40	ns
$t_{d(off)}$ Turn-off delay time			27	40	
t_{r2} Rise time			15	25	
t_{f2} Fall time			7	14	
Q_g Total gate charge	$V_{DS} = 48\text{ V}$, $I_D = 0.7\text{ A}$, $V_{GS} = 10\text{ V}$, See Figure 3		2.1	2.6	nC
$Q_{gs(th)}$ Threshold gate-to-source charge			0.3	0.38	
Q_{gd} Gate-to-drain charge			1.2	1.5	
L_D Internal drain inductance			5		nH
L_S Internal source inductance			5		
R_g Internal gate resistance			0.25		Ω

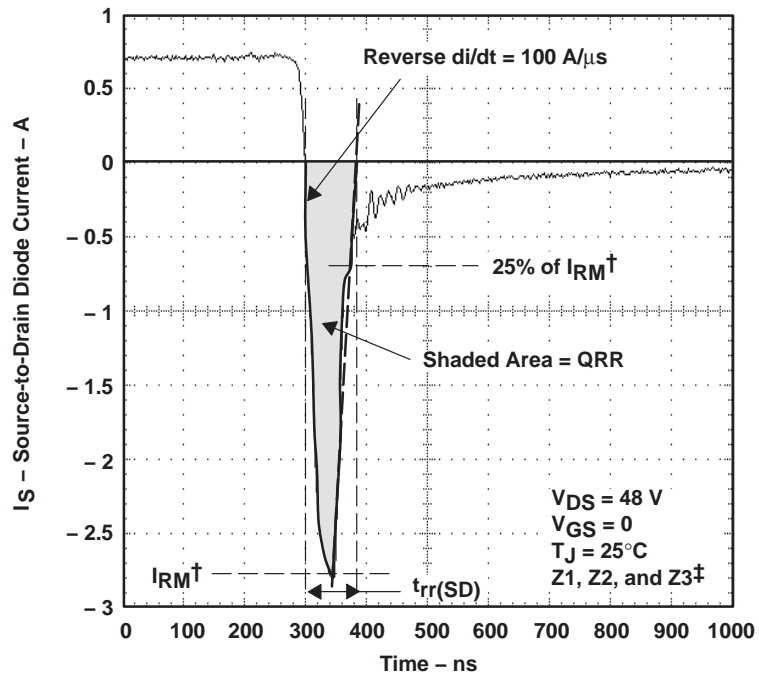
thermal resistance

PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
$R_{\theta JA}$ Junction-to-ambient thermal resistance	See Notes 4 and 7		115		$^\circ\text{C}/\text{W}$
$R_{\theta JB}$ Junction-to-board thermal resistance	See Notes 5 and 7		64		
$R_{\theta JP}$ Junction-to-pin thermal resistance	See Notes 6 and 7		33		

- NOTES:
- Package mounted on an FR4 printed-circuit board with no heatsink.
 - Package mounted on a 24 inch², 4-layer FR4 printed-circuit board.
 - Package mounted in intimate contact with infinite heatsink.
 - All outputs with equal power



PARAMETER MEASUREMENT INFORMATION



$^\dagger I_{RM}$ = maximum recovery current

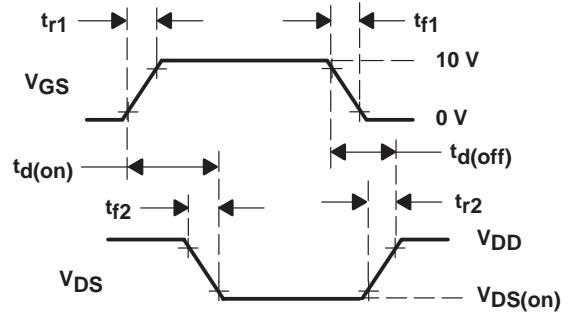
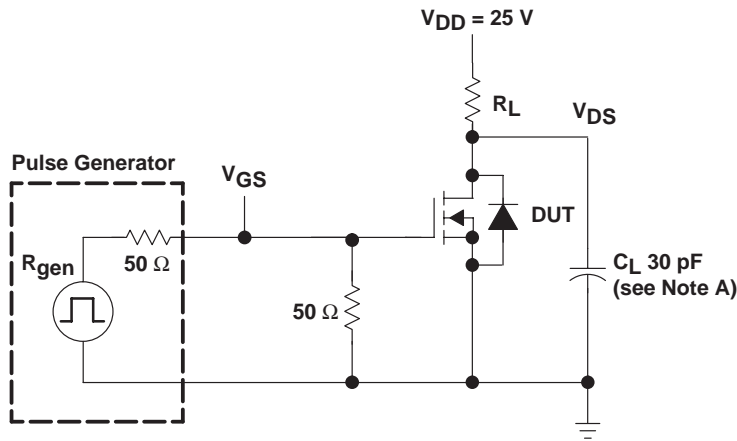
‡ The above waveform is representative of D1, D2, and D3 in shape only.

Figure 1. Reverse-Recovery-Current Waveform of Source-to-Drain Diode

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PARAMETER MEASUREMENT INFORMATION

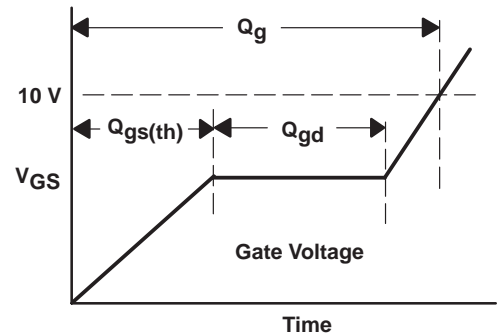
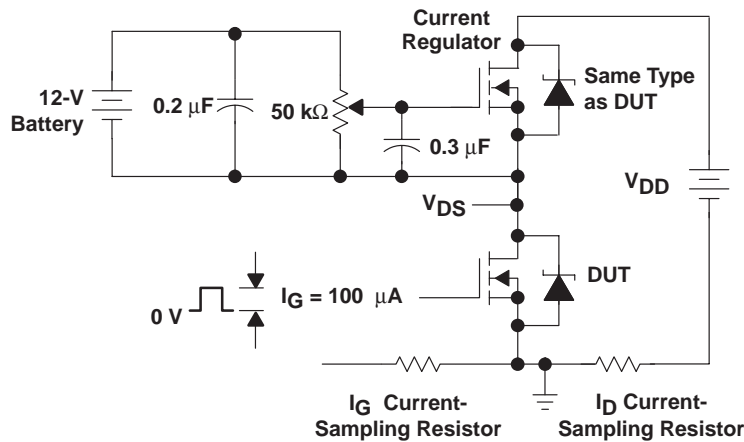


VOLTAGE WAVEFORMS

TEST CIRCUIT

NOTE A: C_L includes probe and jig capacitance.

Figure 2. Resistive-Switching Test Circuit and Voltage Waveforms

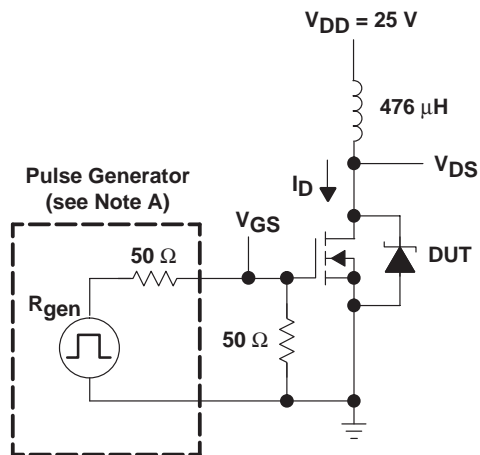


VOLTAGE WAVEFORM

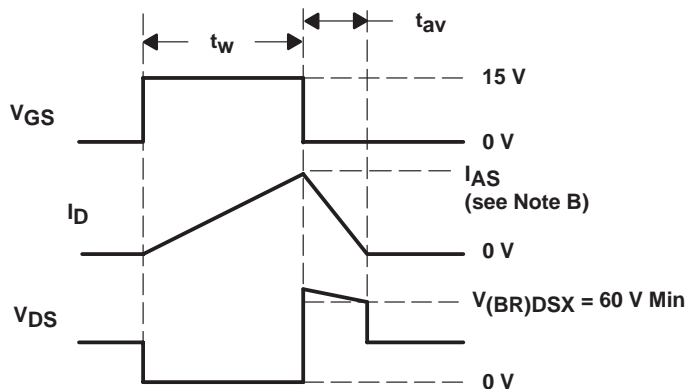
TEST CIRCUIT

Figure 3. Gate-Charge Test Circuit and Waveform

PARAMETER MEASUREMENT INFORMATION



TEST CIRCUIT



VOLTAGE AND CURRENT WAVEFORMS

- NOTES: A. The pulse generator has the following characteristics: $t_r \leq 10$ ns, $t_f \leq 10$ ns, $Z_O = 50 \Omega$.
 B. Input pulse duration (t_w) is increased until peak current $I_{AS} = 5$ A.
 Energy test level is defined as $E_{AS} = \frac{I_{AS} \times V_{(BR)DSX} \times t_{av}}{2} = 10.2$ mJ, where t_{av} = avalanche time.

Figure 4. Single-Pulse Avalanche Energy Test Circuit and Waveforms

TYPICAL CHARACTERISTICS

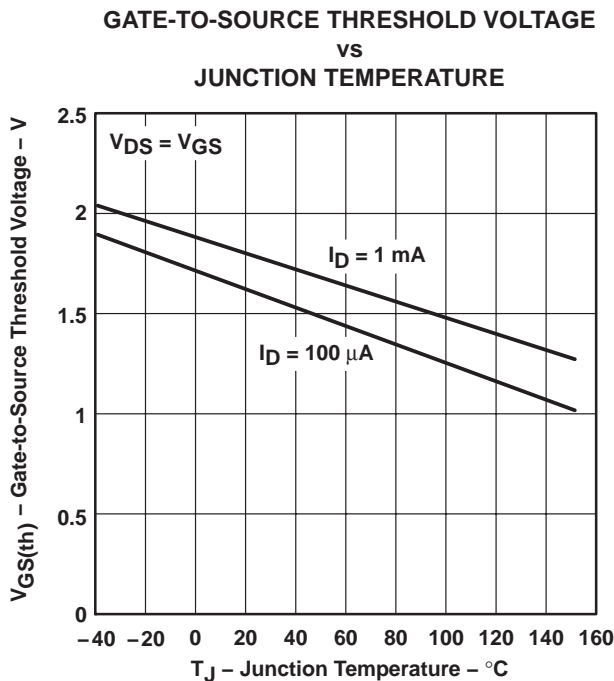


Figure 5

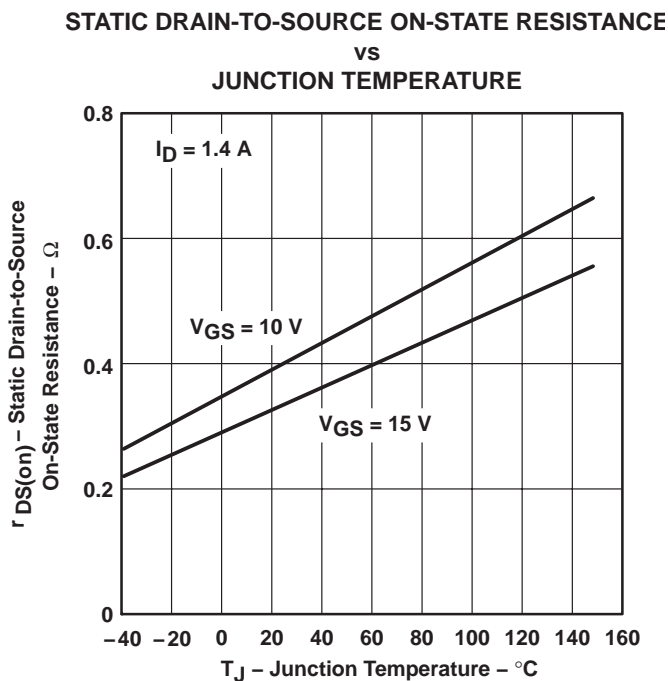


Figure 6

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TYPICAL CHARACTERISTICS

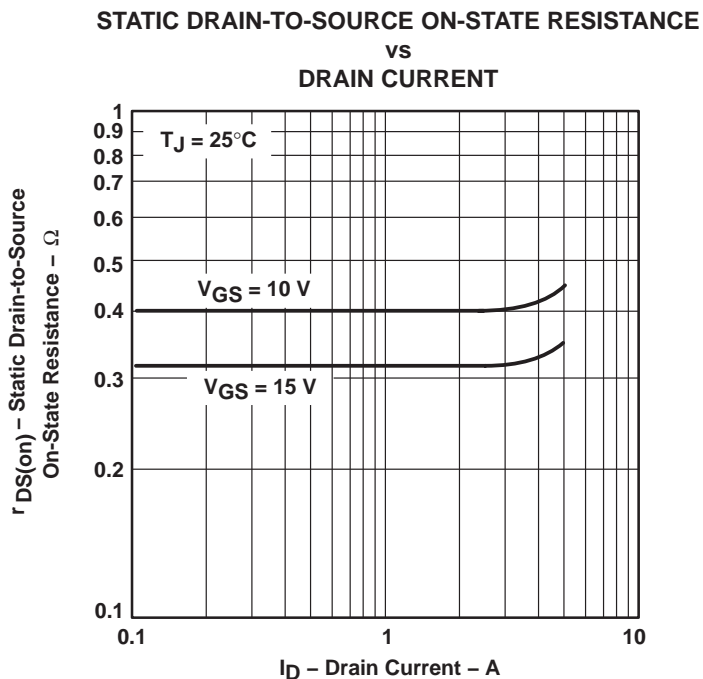


Figure 7

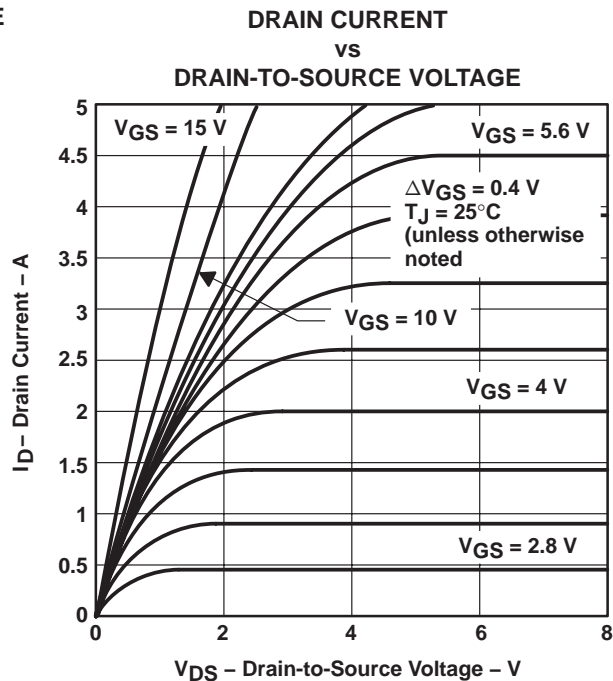


Figure 8

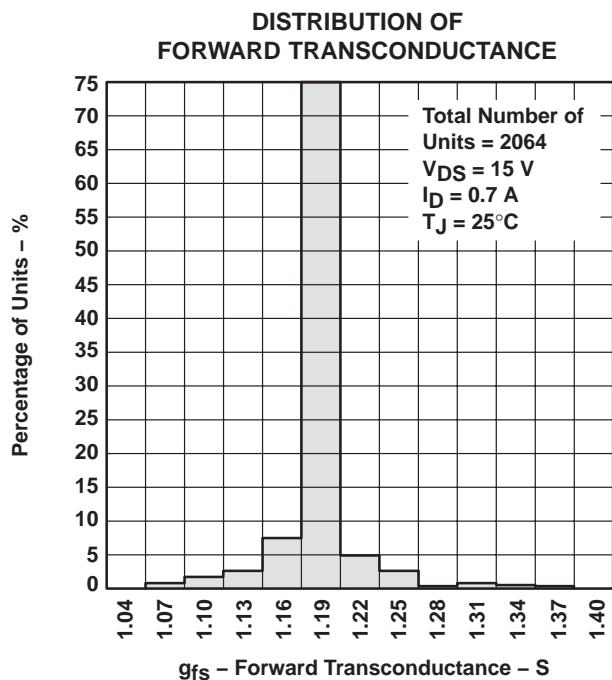


Figure 9

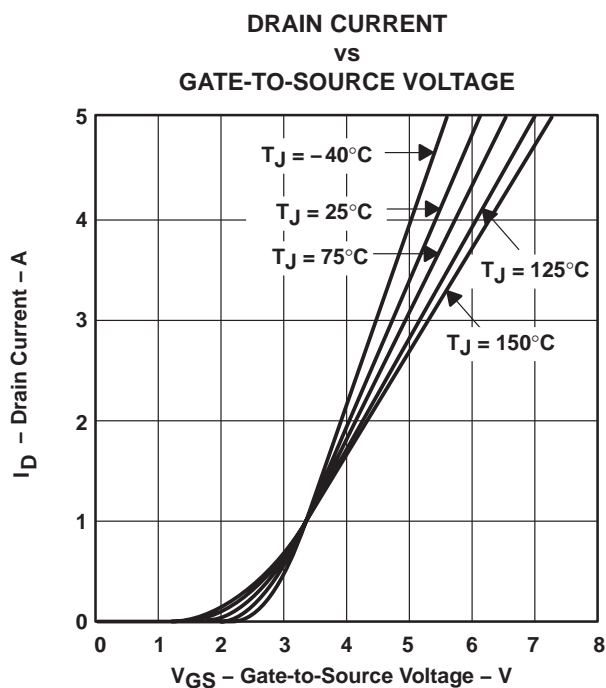


Figure 10

TYPICAL CHARACTERISTICS

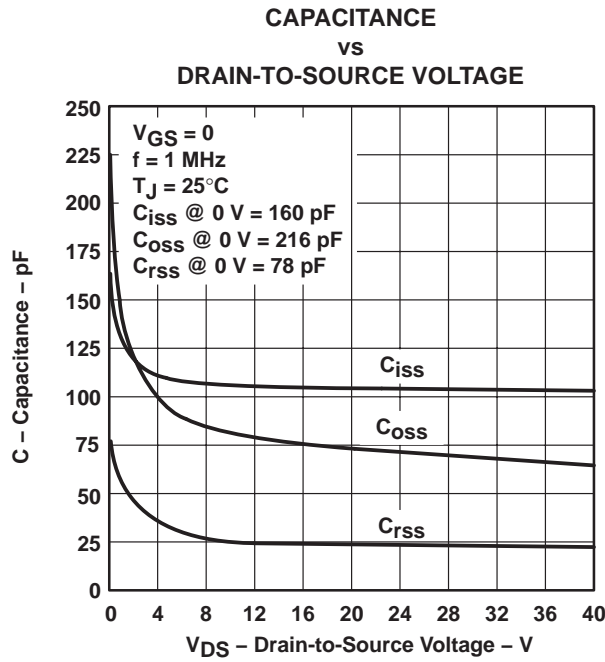


Figure 11

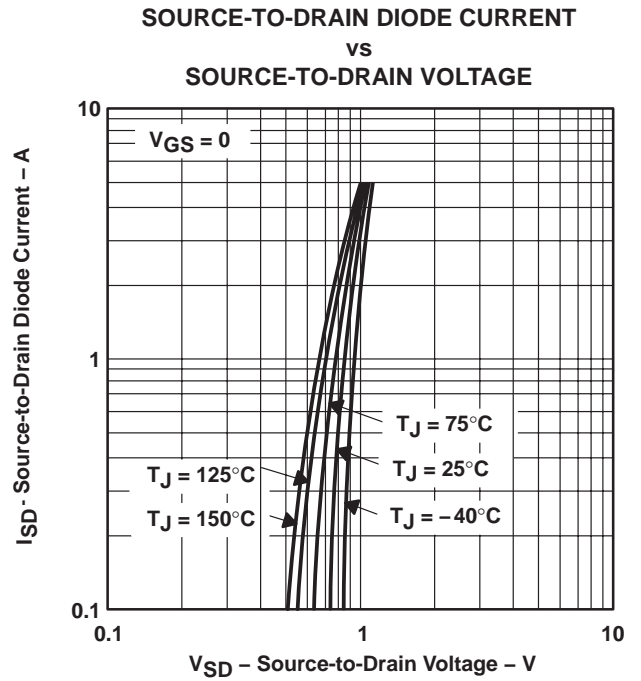


Figure 12

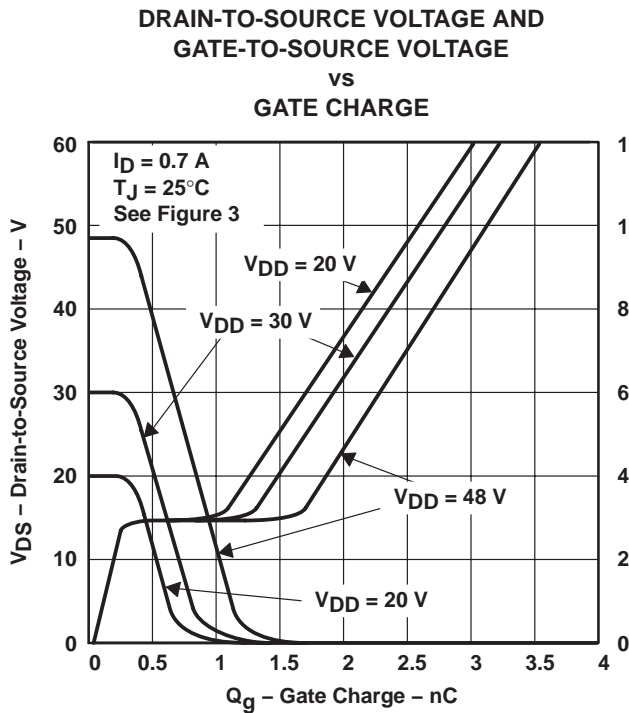


Figure 13

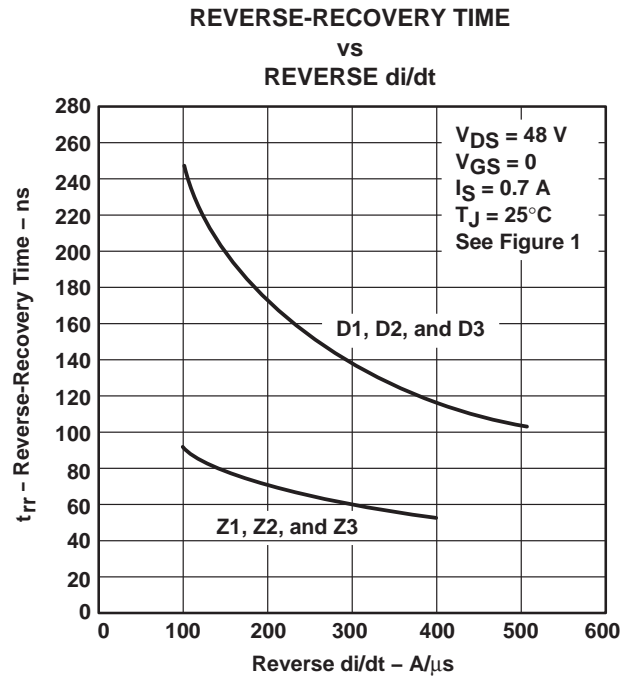


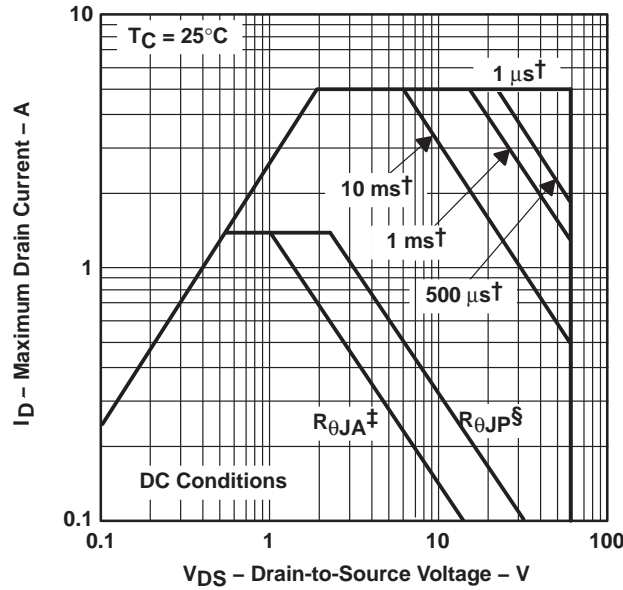
Figure 14

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THERMAL INFORMATION

MAXIMUM DRAIN CURRENT
vs
DRAIN-TO-SOURCE VOLTAGE



† Less than 2% duty cycle
 ‡ Device mounted on FR4 printed-circuit board with no heatsink.
 § Device mounted in intimate contact with infinite heatsink.

Figure 15

MAXIMUM PEAK AVALANCHE CURRENT
vs
TIME DURATION OF AVALANCHE

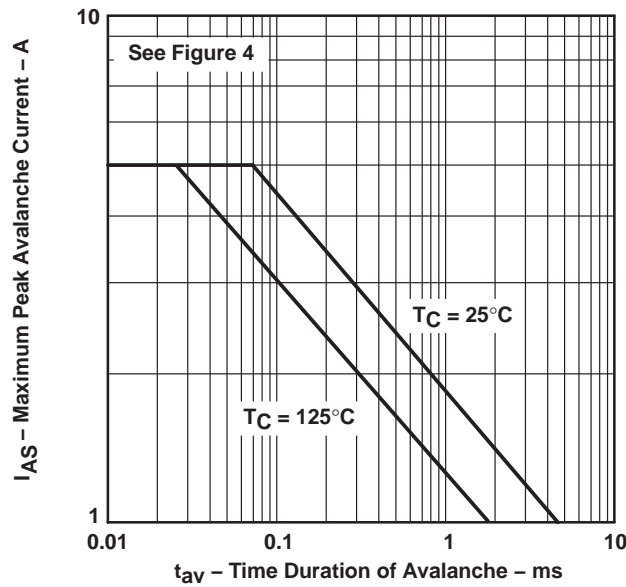
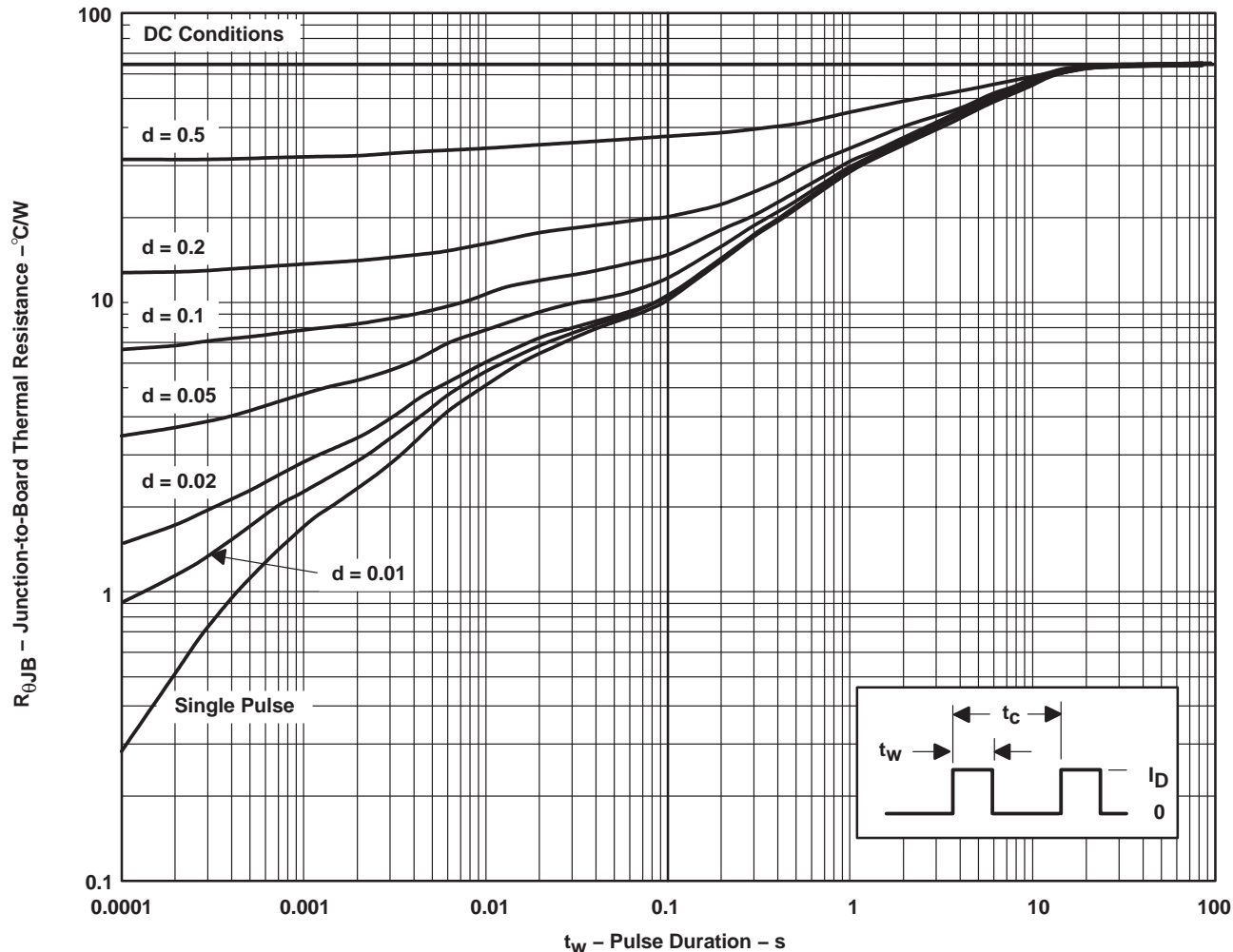


Figure 16

THERMAL INFORMATION

D PACKAGE†
JUNCTION-TO-BOARD THERMAL RESISTANCE
VS
PULSE DURATION



† Device mounted on 24 in², 4-layer FR4 printed-circuit board with no heatsink

NOTE A: $Z_{\theta JB}(t) = r(t) R_{\theta JB}$
 t_w = pulse duration
 t_c = cycle time
 d = duty cycle = t_w/t_c

Figure 17

PACKAGING INFORMATION

Orderable Device	Status ⁽¹⁾	Package Type	Package Drawing	Pins	Package Qty	Eco Plan ⁽²⁾	Lead/Ball Finish	MSL Peak Temp ⁽³⁾
TPIC5303D	OBSOLETE	SOIC	D	16		TBD	Call TI	Call TI

⁽¹⁾ The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

⁽²⁾ Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS) or Green (RoHS & no Sb/Br) - please check <http://www.ti.com/productcontent> for the latest availability information and additional product content details.

TBD: The Pb-Free/Green conversion plan has not been defined.

Pb-Free (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

⁽³⁾ MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

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D (R-PDSO-G16)

PLASTIC SMALL OUTLINE



- NOTES:
- A. All linear dimensions are in inches (millimeters).
 - B. This drawing is subject to change without notice.
 - C. Body length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.006 (0,15) each side.
 - D. Body width does not include interlead flash. Interlead flash shall not exceed 0.017 (0,43) each side.
 - E. Reference JEDEC MS-012 variation AC.

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